

NOTICE - WHEN GOVERNMENT DRAWINGS, SPECIFICATIONS, OR OTHER DATA ARE USED FOR ANY PURPOSE OTHER THAN IN CONNECTION WITH A DEFINITELY RELATED GOVERNMENT PROCUREMENT OPERATION, THE UNITED STATES GOVERNMENT THEREBY INCURS NO RESPONSIBILITY FOR ANY OBLIGATION WHATSOEVER, AND THE FACT THAT THE GOVERNMENT MAY HAVE FORMULATED, FURNISHED, OR IN ANY WAY SUPPLIED THE SAID DRAWINGS, SPECIFICATIONS, OR OTHER DATA IS NOT TO BE REGARDED BY IMPLICATION OR OTHERWISE AS IN ANY MANNER LICENSING THE HOLDER OR ANY OTHER PERSON OR CORPORATION, OR CONVEYING ANY RIGHTS OR PERMISSION TO MANUFACTURE, USE, OR SELL ANY PATENTED INVENTION THAT MAY IN ANY WAY BE RELATED THERETO.

K 1006751

REVISIONS			
BYM	DESCRIPTION	DATE	APPROVAL
F	REPLACES REV E WITH CHANGES AND UPGRADED TO CLASS A RELEASE PER TDRR 02006	7/17/63	JW
G	REVISED PER TDRR 02819	8/28/63	ECM JW
H	REVISED PER TDRR 06009	2/4/64	WPK
J	REVISED PER TDRR 06669		WPK
K	REVISED PER TDRR 13255	10/14	JW

REQUIREMENTS:

1. GENERAL:

- A. INTERPRET DRAWING IN ACCORDANCE WITH STANDARDS PRESCRIBED BY MIL-D-70327.
- B. UNITS SHALL MEET THE REQUIREMENTS OF MIL-S-19500 WITH THE EXCEPTIONS AND ADDITIONS SPECIFIED HEREIN.
- C. THE SUPPLIER SHALL CONFORM TO THE QUALITY ASSURANCE PROVISIONS AS CONTAINED IN ND 1015404, CLASS 2.
- D. UNITS SHALL BE CAPABLE OF MEETING THE QUALIFICATION REQUIREMENTS SPECIFIED IN ND 1002054.
- E. PACKAGING AND PACKING: UNIT PACKAGING AND PACKING SHALL BE IN ACCORDANCE WITH MIL-S-19491 LEVEL A, IN BOTH INSTANCES.

- D. LEAD BEND TEST: EACH LEAD SHALL BE CAPABLE OF WITHSTANDING A LEAD BEND TEST IN ACCORDANCE WITH MIL-STD-750, METHOD 2036, TEST CONDITION E.

NO MECHANICAL DAMAGE OR LACK OF ELECTRICAL PERFORMANCE SHALL BE EVIDENCED AFTER THIS TEST.

- E. LEAD PULL TEST: EACH LEAD SHALL BE CAPABLE OF WITHSTANDING A LEAD PULL TEST IN ACCORDANCE WITH MIL-STD-750, METHOD 2036, TEST CONDITION A WITH A STRAIGHT AXIAL PULL OF 4 POUNDS MINIMUM FOR 1 MINUTE: NO MECHANICAL DAMAGE OR LACK OF ELECTRICAL PERFORMANCE SHALL BE EVIDENCED AFTER THIS TEST.

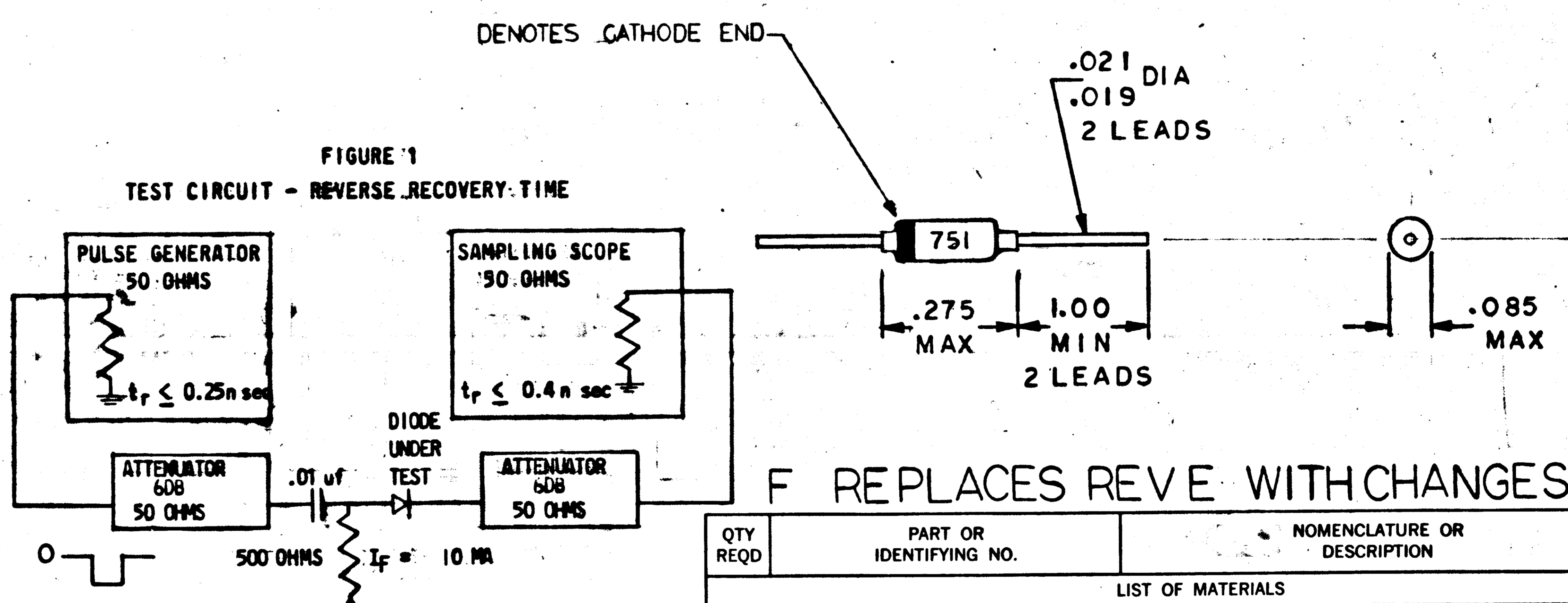
2. ACCEPTANCE AND INSPECTION:

- A. ELECTRICAL CHARACTERISTICS: PER TABLE I.
 - (1) ITEMS 1 THRU 5: 100 PERCENT INSPECTION.
 - (2) ITEMS 6 AND 7: SAMPLE IN ACCORDANCE WITH MIL-STD-105, INSPECTION LEVEL I, AQL OF 4 PERCENT.
- B. MECHANICAL PROPERTIES:
 - (1) DIMENSIONS: PER OUTLINE. SAMPLE IN ACCORDANCE WITH MIL-STD-105, INSPECTION LEVEL I, AQL OF 4 PERCENT.
 - (2) MARKING: DIODES SHALL BE MARKED IN ACCORDANCE WITH MIL-S-19500 WITH A BLACK BAND DENOTING THE CATHODE END AND THE THREE DIGITS 751 PER DRAWING. UNIT PACKAGES AND EXTERIOR SHIPPING CONTAINERS SHALL BE MARKED IN ACCORDANCE WITH ND1002019 AND SHALL INCLUDE THE NASA DRAWING NUMBER, REVISION LETTER AND DASH NUMBER.
 - (3) LEAD MATERIAL: LEAD MATERIAL SHALL BE NICKEL PER PS-1015400. GOLD PLATING PER PARAGRAPH 3.2 IS OPTIONAL. A CERTIFICATE OF COMPLIANCE SHALL ACCOMPANY EACH SHIPMENT.

3. DESIGN:

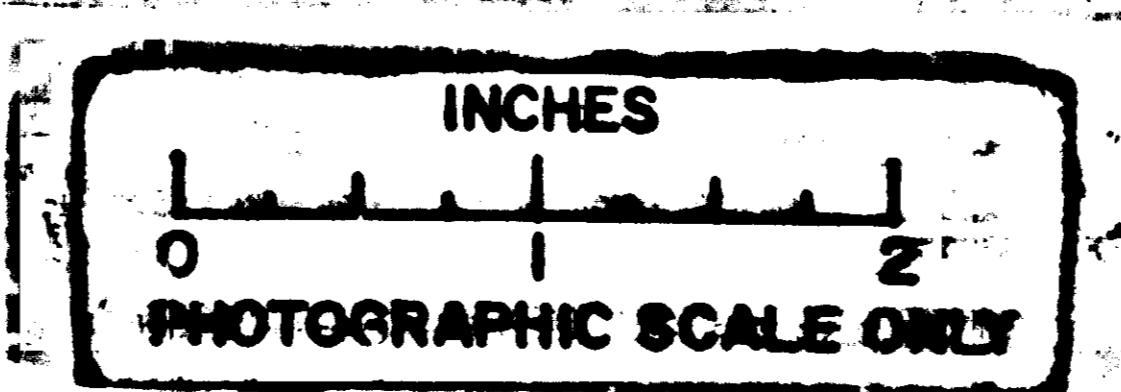
- A. ABSOLUTE MAXIMUM RATINGS:
 - (1) POWER DISSIPATION: 500 MILLIWATTS AT 25 DEGREES CENTIGRADE AMBIENT TEMPERATURE.
 - (2) JUNCTION TEMPERATURE (T_J): FROM MINUS 65 DEGREES CENTIGRADE TO PLUS 175 DEGREES CENTIGRADE.
 - (3) STORAGE TEMPERATURE (T_{STG}): FROM MINUS 65 DEGREES CENTIGRADE TO PLUS 200 DEGREES CENTIGRADE.
 - (4) PEAK FORWARD SURGE CURRENT (i_f SURGE): 1 AMPERE FOR 1 SECOND MINIMUM. REPETATIVE DUTY CYCLE OF 1 PERCENT.
- B. CONSTRUCTION: CLEAR UNPAINTED GLASS, HERMETICALLY SEALED ENCLOSURE.
- C. THERMAL SHOCK: UNITS SHALL BE CAPABLE OF WITHSTANDING A THERMAL SHOCK IN SILICON OIL FROM ZERO DEGREES CENTIGRADE TO +300 DEGREES CENTIGRADE FOR 5 COMPLETE CYCLES. TOTAL IMMERSION TIME EACH HALF CYCLE SHALL BE 30 SECONDS. ELAPSED TRANSFER TIME FROM ONE TEMPERATURE EXTREME TO THE OTHER SHALL NOT EXCEED 3 SECONDS. UNITS SHALL SHOW NO PHYSICAL DAMAGE OR LACK OF ELECTRICAL PERFORMANCE AFTER THERMAL SHOCK.

PROCURE ONLY FROM APPROVED SOURCES LISTED IN ND 1002034 FOR THIS DRAWING.



F REPLACES REV E WITH CHANGES

QTY REQD	PART OR IDENTIFYING NO.	NOMENCLATURE OR DESCRIPTION	FIND NO.
LIST OF MATERIALS			
MIT INSTRUMENTATION LAB CAMBRIDGE, MASS.		MANNED SPACECRAFT CENTER HOUSTON, TEXAS	
DRAWN <i>C. Crisp</i> DATE 2/27/63		SEMICONDUCTOR DEVICE, DIODE	
CHECKED <i>Ruggen</i> DATE 3/11/63			
APPROVAL <i>Eldon C. Hall</i> DATE 4/1/63		SPECIFICATION CONTROL DRAWING	
NASA APPROVAL <i>WJ Rhee</i> DATE 7-17-63		CODE IDENT NO.	NASA DRAWING NO.
MIT APPROVAL <i>L. Halper</i> DATE 7/1/62		SIZE C	1006751
NEXT ASSY		SCALE NONE	SHEET 1 OF 2
USED ON		WT	
APPLICATION			



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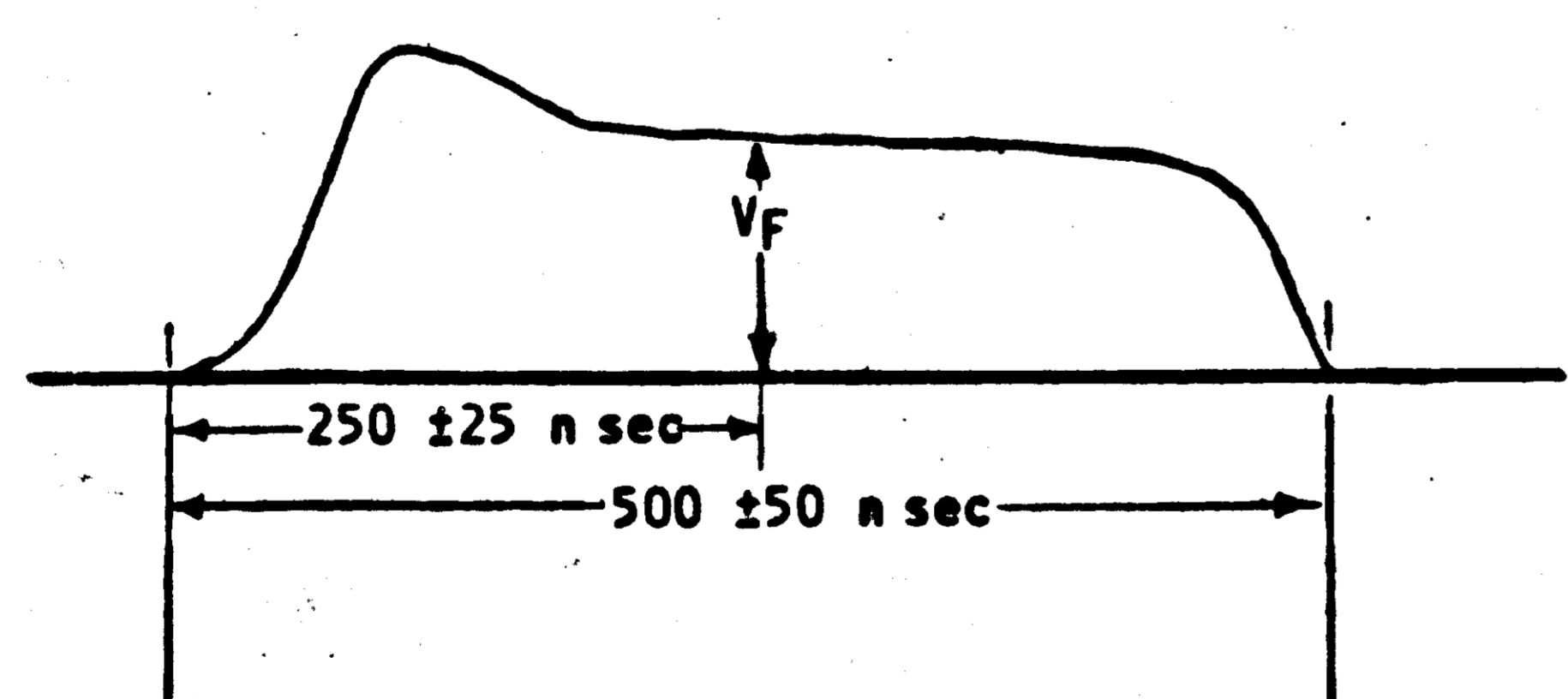
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G	REVISED PER TDRR 02819	8/28/63	see / JG
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TABLE I
ELECTRICAL CHARACTERISTICS

ALL MEASUREMENTS AT 25°C ± 3°C UNLESS OTHERWISE NOTED

ITEM	PARAMETER	SYMBOL	CONDITIONS	LIMITS		UNITS
				MIN	MAX	
1	REVERSE CURRENT	I_R	$V_R = 25$ VOLTS MIN	-	50	NANOAMPS
2	REVERSE BREAKDOWN VOLTAGE	BV	$I_R = 100$ UA	30	-	VOLTS
3	REVERSE RECOVERY TIME (SEE TEST CIRCUIT FIGURE 1)	t_{rr}	$I_F = 10$ MA $I_R = 10$ MA RECOVER TO 1 MA	-	70	NANOSECONDS
4	FORWARD VOLTAGE DROP MIL-STD-750 METHOD 4026	V_F	$I_F = 40$ MA RISE TIME ≤ 100 NANOSEC DUTY CYCLE ≤ 1% SEE FIG. 2	.730	.850	VOLTS
5	FORWARD VOLTAGE DROP MIL-STD-750 METHOD 4026	V_F	$I_F = 400$ MA RISE TIME ≤ 100 NANOSEC DUTY CYCLE ≤ 1%, SEE FIG 2	-	1.35	VOLTS
6	CAPACITANCE	C	$V_R = 1$ VDC $f = 1$ KC		10	PICOFARADS
7	REVERSE CURRENT	I_R	AT 150°C $V_R = 25$ VOLTS MIN		30	MICROAMPS



OUTPUT VOLTAGE WAVE SHAPE
FIGURE 2

F REPLACES REVE WITH CHANGES

QTY REQD	PART OR IDENTIFYING NO.	NOMENCLATURE OR DESCRIPTION	FIND NO.
LIST OF MATERIALS			
MIT INSTRUMENTATION LAB CAMBRIDGE, MASS.		MANNED SPACECRAFT CENTER HOUSTON, TEXAS	
DRAWN <i>G. Cooper</i> DATE 2/17/63 CHECKED <i>H. Hayward</i> 2/25/63		SEMICONDUCTOR DEVICE, DIODE	
DO NOT SCALE THIS DRAWING		SPECIFICATION CONTROL DRAWING	
APPROVAL <i>Edna C. Hall</i> 10/14/63		CODE IDENT NO.	NASA DRAWING NO.
HEAT TREATMENT		SIZE	1006751
NASA APPROVAL <i>W.J. Rhine</i> 7-17-63		C	
FINAL FINISH		SCALE NONE	WT
NEXT ASSY	USED ON	SHEET 2 OF 2	
APPLICATION			

